

Notice of References Cited	Application/Control No. 10/562,577	Applicant(s)/Patent Under Reexamination HEMBD, CHRISTIAN	
	Examiner Arnel C. Lavarias	Art Unit 2872	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,643,534	02-1987	Chun et al.	359/249
	B	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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